

**Search Notes**

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Applicant(s)/Patent under  
Reexamination

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Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
372	25,29.014, 29.015,29. 02,38.	3/19/2006	PN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
See the printout		3/20/2006	PN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See the EAST text search and STIC search in the printout attachments	3/20/2006	PN